TOSHIBA Field Effect Transistor Silicon N-Channel MOS Type (U-MOSIII)

# **TPCT4201**

# Lithium Ion Battery Applications

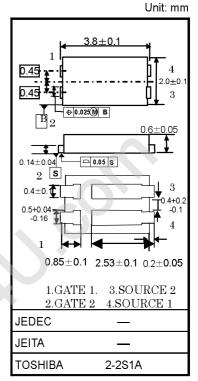
- Lead (Pb) free
- · Small footprint due to a small and thin package
- Low source-source ON-resistance:  $R_{SS(ON)} = 25.5 \text{ m}\Omega$  (typ.)
- High forward transfer admittance: |Y<sub>fs</sub>| = 15 S (typ.)
- Low leakage current: I<sub>SSS</sub> = 10 μA (max) (V<sub>SS</sub> = 20 V)
- Enhancement mode:  $V_{th} = 0.5 \sim 1.2 \text{ V} (V_{SS} = 10 \text{ V}, I_S = 200 \mu\text{A})$
- · Common drain

# Maximum Ratings (Ta = 25°C)

Characteristic			Symbol	Rating	Unit	
Source-source voltage			V <sub>SSS</sub>	20	V	
Gate-source voltage			$V_{GSS}$	±12	V	
Source current	DC	(Note 1)	ls	6	Α	
	Pulse	(Note 1)	Isp	24		
Power dissipation (t = 10 s) (Note 2a, 3)			PD	1.7	W	
Power dissipation (t = 10 s) (Note 2b, 3)		P <sub>D</sub>	0.51	W		
Single-pulse avalanche energy (Note 4)			E <sub>AS</sub>	46.8	mJ	
Avalanche current			I <sub>AR</sub>	6	Α	
Repetitive avalanche energy (Note 2a, 5)			E <sub>AR</sub>	0.17	mJ	
Channel temperature			T <sub>ch</sub>	150	°C	
Storage temperature range			T <sub>stg</sub>	<b>-</b> 55~150	°C	

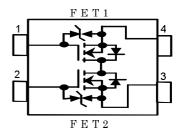
Note: For Notes 1 to 5, see the next page.

This transistor is an electrostatic-sensitive device. Handle with care.



Weight: 0.012 g (typ.)

## **Circuit Configuration**



⚠ WARNING

[Handling Precaution for Power MOSFET in use of Protection

Circuit for Battery Pack]

Flame-retardant resins of UL94-V0 flammability class are used in packages, however, they are not noncombustible.

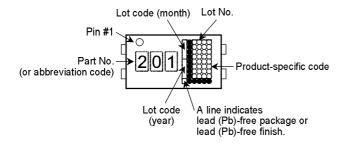
Use a unit, for example PTC Thermistor, which can shut off the power supply if a short-circuit occurs. If the power supply is not shut off on the occurring short-circuit, a large short-circuit current will flow continuously, which may cause the device to catch fire or smoke.

WWW. Date: 2005-04-15

## **Thermal Characteristics**

Characteristic	Symbol	Max	Unit	
Thermal resistance, channel to ambient $(t = 10 \text{ s})$ (Note 2a, 3)	R <sub>th (ch-a)</sub>	76	°C/W	
Thermal resistance, channel to ambient $(t = 10 \text{ s})$ (Note 2b, 3)	R <sub>th (ch-a)</sub>	244	°C/W	

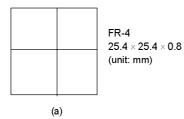
# Marking (Note 6)



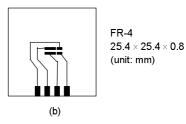
Note 1: Ensure that the channel temperature does not exceed 150°C.

Note 2:

(a) Device mounted on a glass-epoxy board



(b) Device mounted on a glass-epoxy board



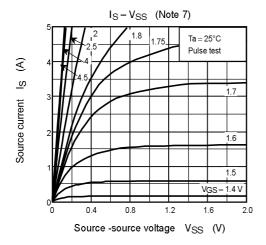
- Note 3: The power dissipation and thermal resistance values are shown for both FETs.
- Note 4:  $V_{SS} = 16 \text{ V}$ ,  $T_{ch} = 25^{\circ}\text{C}$  (initial), L = 1.0 mH,  $R_G = 25 \Omega$ ,  $I_{AR} = 6 \text{ A}$
- Note 5: Repetitive rating: pulse width is limited by max channel temperature.
- Note 6: The circle "o" on the upper left of the marking indicates Pin 1.

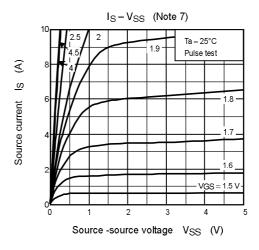
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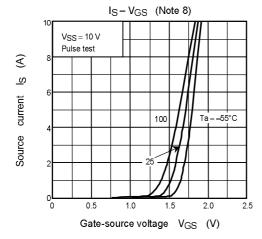
# Electrical Characteristics (Ta = 25°C)

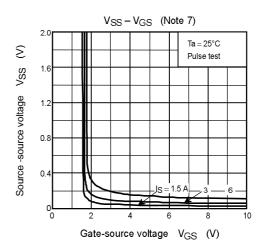
Characteristic		Symbol	Test Condition	Min	Тур.	Max	Unit	
Gate leakage current		IGSS	$V_{GS} = \pm 10 \text{ V}, V_{SS} = 0 \text{ V}$ (Note 8)	_	_	±10	μA	
Source cutoff current		ISSS	V <sub>SS</sub> = 20 V, V <sub>GS</sub> = 0 V (Note 8)		_	10	μA	
Source -source breakdown voltage		V (BR) SSS	I <sub>S</sub> = 10 mA, V <sub>GS</sub> = 0 V (Note 8)	20	_	_	V	
		V (BR) SSX	$I_S = 10 \text{ mA}, V_{GS} = -12 \text{ V}$ (Note 8)	8	_	_		
Gate threshold voltage		V <sub>th</sub>	$V_{SS} = 10 \text{ V}, I_S = 200 \mu\text{A}$ (Note 8)	0.5	_	1.2	V	
Source -source ON-resistance		Rss <sub>(ON)</sub>	V <sub>GS</sub> = 2.5 V, I <sub>S</sub> = 3 A (Note 7)	28	37	49	mΩ	
			V <sub>GS</sub> = 4.0 V, I <sub>S</sub> = 3 A (Note 7)	21	27	32		
			V <sub>GS</sub> = 4.5 V, I <sub>S</sub> = 3 A (Note 7)	19	25.5	31		
Forward transfer admittance		Y <sub>fs</sub>	Vss = 10 V, I <sub>S</sub> = 3 A (Note 8)	7.5	15	_	S	
Input capacitance		C <sub>iss</sub>	., ., ., ., ., ., ., ., ., ., ., ., ., .	_	1740	_	pF	
Reverse transfer capacitance		C <sub>rss</sub>	$V_{SS} = 10 \text{ V}, V_{GS} = 0 \text{ V}, f = 1 \text{ MHz}$	_	180	_		
Output capacitance		C <sub>oss</sub>	(Note 8)	_	260	_		
Switching time	Rise time	t <sub>r</sub>	5 V IS=3 A VOUT	_	28	_	ns ns	
	Turn-on time	t <sub>on</sub>	VGS <sub>0.V</sub>	_	65	_		
	Fall time	t <sub>f</sub>	A 4.7 O.2	_	57	_		
	Turn-off time	t <sub>off</sub>	V <sub>SS</sub> ≃ 15 V Duty ≤ 1%, t <sub>W</sub> = 10 μs (Note 8)	_	250	_		
Total gate charge		Qg	$V_{SS} \simeq 16 \text{ V}, V_{GS} = 5 \text{ V}, I_D = 6 \text{ A}$	_	21	_		
Gate-source charge 1		Q <sub>gs1</sub>	(Note 8)	_	4	_	nC	
Diode (source-source) forward voltage		V <sub>SSF</sub>	I <sub>SR</sub> = 6 A, V <sub>GS</sub> = 0 V (Note 9)		_	-1.2	٧	

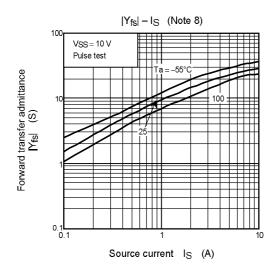
3 2005-04-15

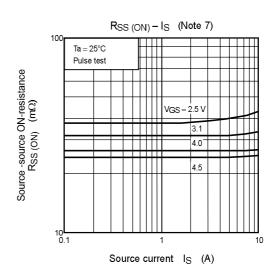




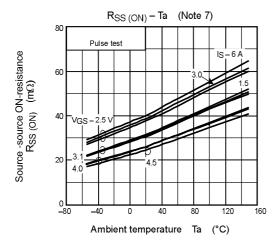


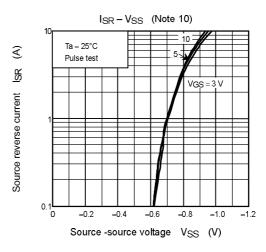


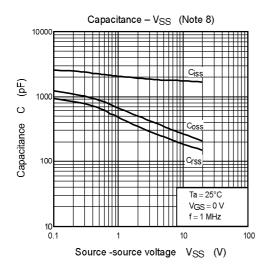


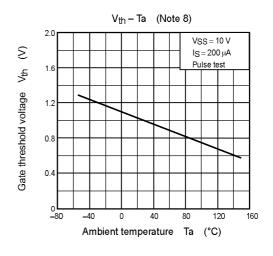


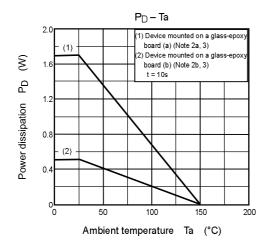
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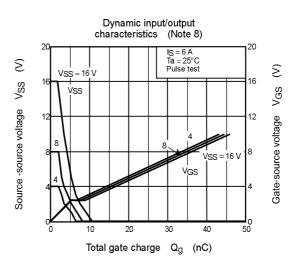


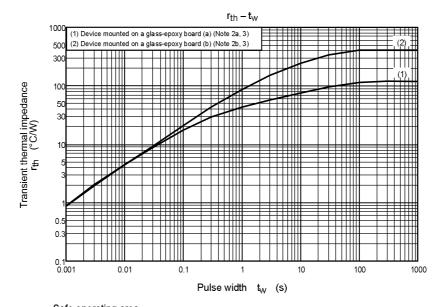


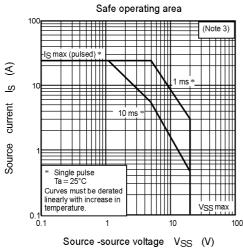












Note 7: The same gate voltage (VGS) is applied to Gate 1 and Gate 2.

Note 8: FET1 measurement: Gate 2 and Source 2 are shorted. FET2 measurement: Gate 1 and Source 1 are shorted.

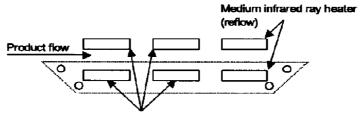
Note 9: FET1 measurement: 4.5 V (V<sub>GS</sub>) is applied to Gate 2. FET2 measurement: 4.5 V (V<sub>GS</sub>) is applied to Gate 1.

Note 10: FET1 measurement: Gate 1 and Source 1 are shorted, VGS is applied between Gate 2 and Source 2. FET2 measurement: Gate 2 and Source 2 are shorted, VGS is applied between Gate 1 and Source 1.

### Note11: [Mounting condition]

Please reflow in one time on our recommended reflow conditions on mounting this product on the substrate. Reflow in 2 times or more, or mounting that exceeds on our recommended reflow conditions may cause deterioration and/or loss of the characteristic of the device, and may lead to breakdown of the device.

- · Use of medium infrared ray reflow
- (1) Heating the top and bottom with long or medium infrared rays is recommended. (See Figure 1.)

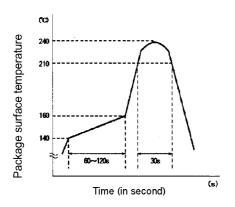


### Long infrared ray heater (preheating)

Figure 1. Heating the top and bottom with long or medium infrared rays

### (2) Example of a recommended temperature profile

Refer to Figure 2 for the recommended temperature profile for when eutectic solder is used. Figure 3 shows the recommended temperature profile for when lead (Pb)-free solder is used.



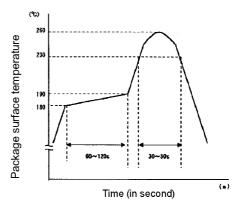


Figure 2. Eutectic recommended temperature profile Figure 3. Lead (Pb)-free recommended temperature profile

- Use of hot air reflow

  For an example of a recommended temperature profile, refer to Figures 2 and 3.
- Use of a soldering iron (for both eutectic and lead (Pb)-free solder)
   Complete soldering within ten seconds for lead temperatures of up to 260°C, or within three seconds for lead temperature of up to 350°C.
  - One terminal may be heated with a soldering iron no more than once.

### Note12: [Element mechanical stress]

This product is very small and thin. External stress may cause breakdown of the package and/or chip, please handle this product within the distortion factor less than 2000  $\mu$   $\epsilon$  or equal in the shaded area shown in the figure 4.

However, please confirm that there is no problem on this product embedded in your product, because the applied stress of this product may vary dependently on the substrate shape, the material, the wiring pattern, the mounting parts arrangement and so on. Moreover, please design your product with the space to protect this product on the mounting upper surface (marked side) from the stress.

The distortion factor  $\varepsilon(\mu\epsilon)$  is defined by the following expressions.

E = 6hS/(L\*L) h: Board thickness S=Bend L= Support width

Use recommended area

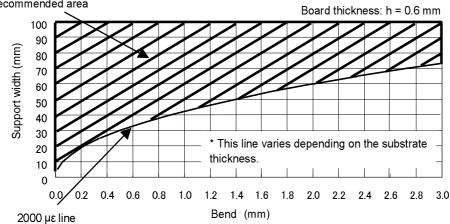


Figure 4. Support width-Bend

Examination method (Reference standard JEITA ED-4702A):

The substrate on which the device is mounted is positioned with the product face down on support stands, with a distance of 31 mm between substrate fulcrums as shown in Figure 5 below. Stress is applied as shown in Figure 6.

Mounting substrate: Glass epoxy substrate FR-4 (JIC C 6484) and size 36 X 6 mm and h = 0.6 mm

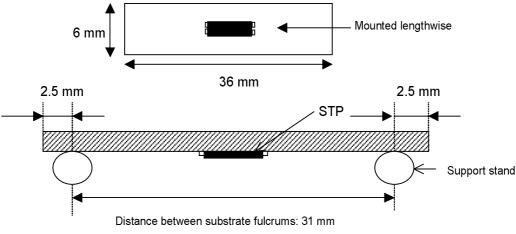
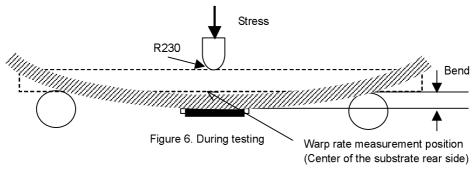


Figure 5. During substrate installation



8 2005-04-15

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